

Notice of References Cited	Application/Control No. 10/535,015		Applicant(s)/Patent Under Reexamination KUWAHARA ET AL.	
	Examiner <i>QML</i> 12/07 Quyen P. Leung		Art Unit 2874	Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-4,078,910	03-1978	Dalgoutte, David George	385/98
*	B	US-4,923,268	05-1990	Xu, Jisen	385/50
*	C	US-5,066,095	11-1991	Dekeyser et al.	385/99
*	D	US-5,185,840	02-1993	Iapicco, Roger	385/100
*	E	US-5,204,925	04-1993	Bonanni et al.	385/89
*	F	US-6,416,232	07-2002	Sasaki et al.	385/55
*	G	US-6,567,603	05-2003	Sukegawa et al.	385/137
*	H	US-6,839,475	01-2005	Kawase et al.	385/14
	I	US-		/	
	J	US-			
	K	US-			
	L	US-			
	M	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N				/	
	O					
	P					
	Q					
	R					
	S					
	T					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	ENGLISH LANGUAGE TRANSLATION OF JP 2002-174736A, COMPLETED ON 12/19/07
	V	ENGLISH LANGUAGE TRANSLATION OF JP 2001-147330A, COMPLETED ON 12/19/07
	W	ENGLISH LANGUAGE TRANSLATION OF JP 2001-141936A, COMPLETED ON 12/19/07
	X	/

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.